Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/679,000	CHANG ET AL.	
Examiner	Art Unit	
Sheng-Jen Tsai	2186	

SEARCHED					
Class	Subclass	Date	Examiner		
714	763	12/20/2005	SJT		
711	103	12/20/2005	SJT		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NO (INCLUDING SEARC		')
	DATE	EXMR
East: "ECC" with "flash" "NAND flash memoy" "MLC NAND flash memory" "hamming code"	12/20/2005	SJT